## Search Notes



Application/Control
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10559840

Reexamination

DEL PRADO PAVON ET AL.

Applicant(s)/Patent Under

Examiner

Liu, Ben H

2616

Art Unit

## **SEARCHED**

Class	Subclass	Date	Examiner
370	470	02-15-2008	Ben H. Liu
370	471	02-15-2008	Ben H. Liu
370	473	02-15-2008	Ben H. Liu
370	469	02-15-2008	Ben H. Liu

## **SEARCH NOTES**

Search Notes	Date	Examiner
Consulted with SPE	02-15-2008	Ben H. Liu
Manual search through EAST search results	02-18-2008	Ben H. Liu

## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner